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Crystal structure of dibenzyldimethylsilane

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In the title compound, $C_{16}H_{20}Si$, a geometry different from an ideal tetrahedron can be observed at the Si atom. The bonds from Si to the benzylic C atoms [Si-C = 1.884 (1) and 1.883 (1) Å] are slightly elongated compared to the Si $-C_{methyl}$ bonds [Si-C = 1.856 (1) and 1.853 (1) Å]. The $C_{benzyl}-Si-C_{benzyl}$ bond angle $[C-Si-C = 107.60 (6)^{\circ}]$ is decreased from the ideal tetrahedral angle by 1.9° . These distortions can be explained easily by Bent's rule. In the crystal, molecules interact only by van der Waals forces.

Keywords: crystal structure; dibenzyldimethylsilane; Bent's rule.

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1. Related literature

The chemistry of silicon exhibits several differences compared to carbon, its lighter congener. Being a representative of the third period, the silicon atom provides deviant reactivity and structural features including the formation of pentavalent intermediates (Chuit *et al.*, 1993; Cypryk & Apeloig, 2002) as well as silicon-specific effects like the α - or β -effect (Whitmore & Sommer, 1946; Sommer & Whitmore, 1946). For the correlation of bond lengths and angles with the electronegativity of substituents, see: Bent (1961) and for the same effect in the related compound MePh₂SiBn, see: Koller *et al.* (2015). For the reaction of silyllithium reagents to benzylsilanes, see: Strohmann *et al.* (2004). For the α -lithiation of methylsilanes, see: Däschlein *et al.* (2010). For the structure and reactivity of α -lithiated benzylsilanes, see: Ott *et al.* (2008), Strohmann *et al.* (2002). 2. Experimental

2.1. Crystal data

 $C_{16}H_{20}Si$ $M_r = 240.41$ Monoclinic, $P2_1/n$ a = 6.1045 (2) Å b = 19.8512 (6) Å c = 11.8396 (3) Å $\beta = 98.069$ (3)°

2.2. Data collection

2.3. Refinement

 $wR(F^2) = 0.088$

2800 reflections

S = 1.06

 $R[F^2 > 2\sigma(F^2)] = 0.033$

Oxford Diffraction Xcalibur, Sapphire3 diffractometer Absorption correction: multi-scan (*CrysAlis PRO*; Oxford Diffraction, 2010) $T_{min} = 0.940, T_{max} = 1.000$ $V = 1420.54 (7) \text{ Å}^{3}$ Z = 4 Mo K\alpha radiation $\mu = 0.14 \text{ mm}^{-1}$ T = 173 K 0.2 \times 0.1 \times 0.1 mm

21539 measured reflections 2800 independent reflections 2280 reflections with $I > 2\sigma(I)$ $R_{\text{int}} = 0.035$

156 parameters H-atom parameters constrained $\Delta \rho_{max} = 0.29 \text{ e } \text{\AA}^{-3}$ $\Delta \rho_{min} = -0.24 \text{ e } \text{\AA}^{-3}$

Data collection: *CrysAlis PRO* (Oxford Diffraction, 2010); cell refinement: *CrysAlis PRO*; data reduction: *CrysAlis PRO*; program(s) used to solve structure: *SHELXS97* (Sheldrick, 2008); program(s) used to refine structure: *SHELXL2014* (Sheldrick, 2015); molecular graphics: *OLEX2* (Dolomanov *et al.*, 2009); software used to prepare material for publication: *OLEX2*.

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Supporting information for this paper is available from the IUCr electronic archives (Reference: FK2087).

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S1. Structural commentary

The chemistry of silicon exhibits several differences compared to carbon, its lighter congener. Being a representative of the third period, the silicon atom provides deviant reactivity and structural features. Among others, the formation of pentavalent intermediates (Chuit *et al.*, 1993; Cypryk & Apeloig, 2002) as well as silicon-specific effects like the α - or β -effect (Whitmore & Sommer, 1946; Sommer & Whitmore, 1946) can be listed. Last but not least, the low electronegativity of silicon compared to carbon is a feature that has to be considered.

In the title compound, two different types of Si–C bonds can be observed. Comparing the Si– C_{methyl} bonds Si1–C1 [1.856 (1) Å] and Si1–C2 [1.853 (1) Å] to the Si– C_{benzyl} bonds Si1–C3 [1.884 (1) Å] and Si1–C10 [1.883 (1) Å], a difference of 0.03 Å becomes obvious. This divergence can be explained by Bent's rule (Bent, 1961): atomic s-character is concentrated in orbitals forming bonds with electropositive substituents. In return, the orbitals of bonds with electronegative substituents are featured by a high p-character, thus leading to elongated bond lengths and bond angles shifted towards 90°. In the title compound, the carbon atoms directly bonded to the silicon center exhibit unequal electronegativities. Due to the ability of benzylic carbon atoms to stabilize a negative charge, they are of higher electronegativity than carbon atoms of methyl groups. According to Bent's rule, atomic p-character is concentrated in the orbitals forming the Si– C_{benzyl} bonds to a higher level than in the Si– C_{methyl} bonds. This assumption is furthermore affirmed by the C—Si—C bond angles observed in the title compound. The bond angle between the methyl carbon atoms is very close to the ideal tetrahedral angle [C1–Si1–C2 109.89 (7)°], the angle between the benzyl carbon atoms is slightly smaller [C3–Si1–C10 107.60 (6)°], as it would be expected for bonds formed by orbitals with increased p-character.

The same effect can be observed in the related compound MePh₂SiBn (Koller *et al.*, 2015). According to the title compound, the Si– C_{methyl} bond is the shortest [1.853 (1) Å], and the Si– C_{benzyl} bond is the longest [1.876 (2) Å]. The Si– C_{phenyl} bonds are settled in between at 1.873 (1) Å and 1.869 (1) Å, respectively.

S2. Refinement

Crystal data, data collection and structure refinement details are summarized in Table 1.

Hydrogen atoms were located from difference Fourier maps, refined at idealized positions riding on the carbon atoms with isotropic displacement parameters $U_{iso}(H) = 1.2U_{eq}(C)$ or $1.5U_{eq}(-CH_3)$ and C-H = 0.95-0.99 Å. All CH₃ hydrogen atoms were allowed to rotate but not to tip.



Figure 1

Molecular structure of the title compound with anisotropic displacement ellipsoids drawn at 50% probability level.

Dibenzyldimethylsilane

Crystal data

C₁₆H₂₀Si $M_r = 240.41$ Monoclinic, $P2_1/n$ a = 6.1045 (2) Å b = 19.8512 (6) Å c = 11.8396 (3) Å $\beta = 98.069$ (3)° V = 1420.54 (7) Å³ Z = 4

Data collection

Oxford Diffraction Xcalibur, Sapphire3 diffractometer Radiation source: Enhance (Mo) X-ray Source Graphite monochromator Detector resolution: 16.0560 pixels mm⁻¹ ω scans Absorption correction: multi-scan (*CrysAlis PRO*; Oxford Diffraction, 2010) $T_{\min} = 0.940, T_{\max} = 1.000$

Refinement

Refinement on F^2 Hydrogen site location: inferred from Least-squares matrix: full neighbouring sites $R[F^2 > 2\sigma(F^2)] = 0.033$ H-atom parameters constrained $wR(F^2) = 0.088$ $w = 1/[\sigma^2(F_o^2) + (0.0528P)^2 + 0.0485P]$ *S* = 1.06 where $P = (F_0^2 + 2F_c^2)/3$ 2800 reflections $(\Delta/\sigma)_{\rm max} < 0.001$ 156 parameters $\Delta \rho_{\rm max} = 0.29 \ {\rm e} \ {\rm \AA}^{-3}$ 0 restraints $\Delta \rho_{\rm min} = -0.24 \text{ e} \text{ Å}^{-3}$

Special details

Experimental. CrysAlisPro, Oxford Diffraction Ltd., Version 1.171.33.55 (release 05-01-2010 CrysAlis171 .NET) (compiled Jan 5 2010,16:28:46) Empirical absorption correction using spherical harmonics, implemented in SCALE3 ABSPACK scaling algorithm.

F(000) = 520 $D_x = 1.124 \text{ Mg m}^{-3}$ Mo K\alpha radiation, $\lambda = 0.71073 \text{ Å}$ Cell parameters from 10295 reflections $\theta = 2.7-29.2^{\circ}$ $\mu = 0.14 \text{ mm}^{-1}$ T = 173 KBlock, colourless $0.2 \times 0.1 \times 0.1 \text{ mm}$

21539 measured reflections 2800 independent reflections 2280 reflections with $I > 2\sigma(I)$ $R_{int} = 0.035$ $\theta_{max} = 26.0^\circ, \theta_{min} = 2.7^\circ$ $h = -7 \rightarrow 7$ $k = -24 \rightarrow 24$ $l = -14 \rightarrow 14$ **Geometry**. All e.s.d.'s (except the e.s.d. in the dihedral angle between two l.s. planes) are estimated using the full covariance matrix. The cell e.s.d.'s are taken into account individually in the estimation of e.s.d.'s in distances, angles and torsion angles; correlations between e.s.d.'s in cell parameters are only used when they are defined by crystal symmetry. An approximate (isotropic) treatment of cell e.s.d.'s is used for estimating e.s.d.'s involving l.s. planes.

	x	У	Ζ	$U_{ m iso}$ */ $U_{ m eq}$
Si1	0.13789 (6)	0.14013 (2)	0.03688 (3)	0.01945 (12)
C11	0.1208 (2)	0.10937 (7)	-0.19747 (11)	0.0221 (3)
С9	0.4409 (2)	0.16077 (7)	0.32428 (12)	0.0286 (3)
Н9	0.5690	0.1513	0.2898	0.034*
C12	-0.0953 (2)	0.10519 (8)	-0.25332 (12)	0.0301 (3)
H12	-0.2001	0.1387	-0.2402	0.036*
C16	0.2691 (2)	0.05980 (7)	-0.22010 (12)	0.0299 (3)
H16	0.4177	0.0616	-0.1833	0.036*
C5	0.0758 (2)	0.20416 (7)	0.31346 (12)	0.0284 (3)
Н5	-0.0500	0.2252	0.2716	0.034*
C3	0.2631 (2)	0.20813 (7)	0.13668 (11)	0.0243 (3)
H3A	0.4179	0.2157	0.1238	0.029*
H3B	0.1805	0.2506	0.1185	0.029*
C10	0.1896 (2)	0.16338 (7)	-0.11131 (11)	0.0243 (3)
H10A	0.1076	0.2052	-0.1350	0.029*
H10B	0.3493	0.1727	-0.1100	0.029*
C4	0.2605 (2)	0.19144 (7)	0.26040 (11)	0.0220 (3)
C8	0.4376 (3)	0.14376 (8)	0.43742 (13)	0.0368 (4)
H8	0.5636	0.1233	0.4800	0.044*
C2	0.2653 (2)	0.05739 (7)	0.07812 (12)	0.0263 (3)
H2A	0.2290	0.0443	0.1531	0.039*
H2B	0.4263	0.0607	0.0816	0.039*
H2C	0.2081	0.0234	0.0215	0.039*
C1	-0.1645 (2)	0.13650 (8)	0.04158 (13)	0.0306 (3)
H1A	-0.2328	0.1042	-0.0153	0.046*
H1B	-0.2293	0.1812	0.0248	0.046*
H1C	-0.1912	0.1222	0.1177	0.046*
C6	0.0720 (3)	0.18677 (8)	0.42632 (13)	0.0356 (4)
H6	-0.0561	0.1959	0.4610	0.043*
C13	-0.1588 (3)	0.05285 (9)	-0.32761 (12)	0.0401 (4)
H13	-0.3072	0.0506	-0.3646	0.048*
C14	-0.0101 (3)	0.00404 (9)	-0.34877 (12)	0.0444 (5)
H14	-0.0549	-0.0320	-0.3997	0.053*
C7	0.2521 (3)	0.15639 (8)	0.48868 (13)	0.0378 (4)
H7	0.2489	0.1442	0.5660	0.045*
C15	0.2045 (3)	0.00808 (8)	-0.29506 (13)	0.0414 (4)
H15	0.3090	-0.0251	-0.3098	0.050*

Fractional atomic coordinates and isotropic or equivalent isotropic displacement parameters $(Å^2)$

supporting information

	T 711	T (1)	T 1 22	* 12	T 1 2	T 1)2
	U^{Π}	U^{22}	U^{33}	U^{12}	U^{13}	U^{23}
Si1	0.0205 (2)	0.0177 (2)	0.0207 (2)	-0.00025 (15)	0.00477 (14)	-0.00023 (15)
C11	0.0291 (7)	0.0214 (7)	0.0167 (6)	-0.0014 (6)	0.0054 (5)	0.0054 (5)
C9	0.0277 (8)	0.0259 (8)	0.0318 (8)	-0.0007 (6)	0.0030 (6)	-0.0024 (6)
C12	0.0329 (8)	0.0329 (9)	0.0239 (7)	0.0003 (7)	0.0021 (6)	0.0089 (6)
C16	0.0351 (8)	0.0315 (8)	0.0240 (7)	0.0050 (7)	0.0076 (6)	0.0017 (6)
C5	0.0306 (8)	0.0268 (8)	0.0281 (7)	0.0025 (6)	0.0051 (6)	-0.0074 (6)
C3	0.0268 (7)	0.0211 (7)	0.0251 (7)	-0.0015 (6)	0.0047 (6)	-0.0010 (6)
C10	0.0288 (8)	0.0201 (7)	0.0245 (7)	-0.0011 (6)	0.0054 (6)	0.0024 (6)
C4	0.0264 (7)	0.0162 (7)	0.0233 (7)	-0.0040 (5)	0.0032 (6)	-0.0054 (5)
C8	0.0434 (9)	0.0314 (9)	0.0324 (8)	-0.0012 (7)	-0.0063 (7)	0.0023 (7)
C2	0.0294 (8)	0.0221 (8)	0.0277 (7)	0.0009 (6)	0.0054 (6)	0.0026 (6)
C1	0.0244 (7)	0.0329 (9)	0.0352 (8)	0.0005 (6)	0.0062 (6)	-0.0046 (7)
C6	0.0447 (9)	0.0331 (9)	0.0320 (8)	-0.0048 (7)	0.0156 (7)	-0.0109 (7)
C13	0.0446 (9)	0.0497 (11)	0.0230 (8)	-0.0177 (8)	-0.0053 (7)	0.0082 (7)
C14	0.0786 (13)	0.0339 (9)	0.0212 (7)	-0.0190 (9)	0.0084 (8)	-0.0050(7)
C7	0.0630 (11)	0.0301 (9)	0.0206 (7)	-0.0107 (8)	0.0067 (7)	-0.0029 (6)
C15	0.0659 (12)	0.0296 (9)	0.0318 (8)	0.0052 (8)	0.0175 (8)	-0.0025 (7)

Atomic displacement parameters $(Å^2)$

Geometric parameters (Å, °)

Sil—C3	1.8838 (14)	C3—C4	1.5040 (18)	
Sil—C10	1.8832 (13)	C10—H10A	0.9900	
Sil—C2	1.8534 (14)	C10—H10B	0.9900	
Sil—Cl	1.8563 (14)	C8—H8	0.9500	
C11—C12	1.3928 (19)	C8—C7	1.381 (2)	
C11—C16	1.3887 (19)	C2—H2A	0.9800	
C11—C10	1.4988 (19)	C2—H2B	0.9800	
С9—Н9	0.9500	C2—H2C	0.9800	
С9—С4	1.3861 (19)	C1—H1A	0.9800	
С9—С8	1.384 (2)	C1—H1B	0.9800	
С12—Н12	0.9500	C1—H1C	0.9800	
C12—C13	1.381 (2)	С6—Н6	0.9500	
С16—Н16	0.9500	C6—C7	1.375 (2)	
C16—C15	1.378 (2)	C13—H13	0.9500	
С5—Н5	0.9500	C13—C14	1.375 (2)	
C5—C4	1.3888 (19)	C14—H14	0.9500	
С5—С6	1.383 (2)	C14—C15	1.376 (2)	
С3—НЗА	0.9900	С7—Н7	0.9500	
С3—Н3В	0.9900	C15—H15	0.9500	
C10—Si1—C3	107.60 (6)	C9—C4—C5	117.79 (13)	
C2-Si1-C3	110.57 (6)	C9—C4—C3	120.81 (12)	
C2—Si1—C10	110.09 (6)	C5—C4—C3	121.37 (12)	
C2—Si1—C1	109.89 (7)	C9—C8—H8	119.8	
C1—Si1—C3	109.07 (6)	C7—C8—C9	120.35 (15)	
		2. 22 09		

C1—Si1—C10	109.58 (6)	С7—С8—Н8	119.8
C12—C11—C10	121.48 (13)	Si1—C2—H2A	109.5
C16—C11—C12	117.78 (13)	Si1—C2—H2B	109.5
C16—C11—C10	120.68 (12)	Si1—C2—H2C	109.5
С4—С9—Н9	119.4	H2A—C2—H2B	109.5
С8—С9—Н9	119.4	H2A—C2—H2C	109.5
C8—C9—C4	121.11 (14)	H2B—C2—H2C	109.5
C11—C12—H12	119.7	Si1—C1—H1A	109.5
C13—C12—C11	120.64 (15)	Si1—C1—H1B	109.5
C13—C12—H12	119.7	Si1—C1—H1C	109.5
C11-C16-H16	119.4	H1A—C1—H1B	109.5
C15—C16—C11	121.11 (14)	H1A—C1—H1C	109.5
C15—C16—H16	119.4	H1B—C1—H1C	109.5
С4—С5—Н5	119.5	С5—С6—Н6	119.7
С6—С5—Н5	119.5	C7—C6—C5	120.51 (15)
C6—C5—C4	121.09 (14)	С7—С6—Н6	119.7
Si1—C3—H3A	108.9	C12—C13—H13	119.6
Si1—C3—H3B	108.9	C14—C13—C12	120.86 (15)
НЗА—СЗ—НЗВ	107.7	C14—C13—H13	119.6
C4—C3—Si1	113.22 (9)	C13—C14—H14	120.5
C4—C3—H3A	108.9	C13—C14—C15	119.01 (15)
C4—C3—H3B	108.9	C15—C14—H14	120.5
Si1—C10—H10A	109.0	С8—С7—Н7	120.4
Si1—C10—H10B	109.0	C6—C7—C8	119.14 (14)
C11—C10—Si1	113.02 (9)	С6—С7—Н7	120.4
C11-C10-H10A	109.0	C16—C15—H15	119.7
C11-C10-H10B	109.0	C14—C15—C16	120.60 (15)
H10A—C10—H10B	107.8	C14—C15—H15	119.7
Si1—C3—C4—C9	93.41 (13)	C10-C11-C12-C13	-176.30 (13)
Si1—C3—C4—C5	-84.53 (15)	C10-C11-C16-C15	176.82 (13)
C11—C12—C13—C14	-0.5 (2)	C4—C9—C8—C7	0.8 (2)
C11-C16-C15-C14	-0.5 (2)	C4—C5—C6—C7	0.0 (2)
C9—C8—C7—C6	-0.8 (2)	C8—C9—C4—C5	-0.4 (2)
C12—C11—C16—C15	-0.2 (2)	C8—C9—C4—C3	-178.39 (13)
C12-C11-C10-Si1	86.49 (14)	C2—Si1—C3—C4	-52.05 (11)
C12—C13—C14—C15	-0.3 (2)	C2—Si1—C10—C11	52.86 (11)
C16-C11-C12-C13	0.7 (2)	C1—Si1—C3—C4	68.89 (11)
C16-C11-C10-Si1	-90.42 (14)	C1—Si1—C10—C11	-68.10 (11)
C5—C6—C7—C8	0.4 (2)	C6—C5—C4—C9	0.0 (2)
C3—Si1—C10—C11	173.44 (9)	C6—C5—C4—C3	177.97 (13)
C10—Si1—C3—C4	-172.32 (9)	C13—C14—C15—C16	0.8 (2)